TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSII)

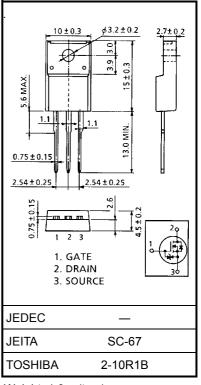
2SK3662

Switching Regulator, DC–DC Converter, Motor Drive Applications

- Low drain-source ON resistance: R_{DS} (ON) = 9.4 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 55 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 100 \ \mu A (max) (V_{DS} = 60 \ V)$
- Enhancement-mode : V_{th} = 1.3 to 2.5 V (V_{DS} = 10 V, I_D = 1 mA)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	60	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	35	А	
	Pulse (Note 1)	I _{DP}	105	A	
Drain power dissipation	on (Tc = 25°C)	PD	35	W	
Single pulse avalanche energy (Note 2)		E _{AS}	204	mJ	
Avalanche current		I _{AR}	35	А	
Repetitive avalanche energy (Note 3)		E _{AR}	3.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	



Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	3.57	°C/W
Thermal resistance, channel to ambient	R _{th (ch−a)}	62.5	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_DD = 25 V, T_{ch} = 25 ^{\circ}C (initial), L = 227 μ H, I_{AR} = 35 A, R_G = 25 Ω

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

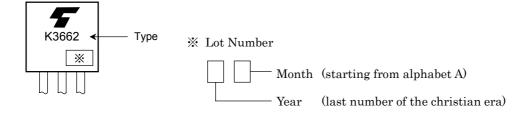
Electrical Characteristics (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-off curr	ent	I _{DSS}	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			100	μA
Drain-source breakdown voltage		V (BR) DSS	$I_{D} = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60			V
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	40		_	
Gate threshold voltage		V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.3		2.5	V
Drain-source ON resistance		Den service	$V_{GS} = 4 V, ID = 18 A$		12.5	19	mΩ
		R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 18 \text{ A}$		9.4	12.5	
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 18 \text{ A}$	28	55	_	S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		5120	_	pF
Reverse transfer capacitance		C _{rss}			300	_	
Output capacitance		C _{oss}			500		
Switching time	Rise time	tr	V_{GS} $0 V$ C_{G} $V_{DD} \approx 30 V$ $U_{D} = 18 A$ V_{OUT} C_{G} C_{G		6	_	- ns
	Turn-on time	t _{on}			19	_	
	Fall time	t _f			20	_	
	Turn-off time	t _{off}			115		
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 48 V, V _{GS} = 10 V,		91		nC
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, \text{ V}_{GS} = 10 \text{ V},$ $I_{D} = 35 \text{ A}$	_	70		
Gate-drain ("miller") charge		Q _{gd}			21		

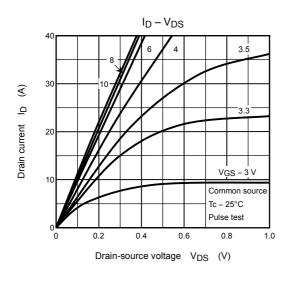
Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

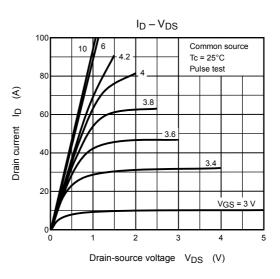
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	35	А
Pulse drain reverse current (Note 1)	I _{DRP}	—		_	105	А
Forward voltage (diode)	V _{DS2F}	I _{DR1} = 35 A, V _{GS} = 0 V			-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 35 \text{ A}, V_{GS} = 0 \text{ V},$		60		ns
Reverse recovery charge	Q _{rr}	$dI_{DR}/dt = 50 \text{ A}/\mu \text{s}$		58		nC

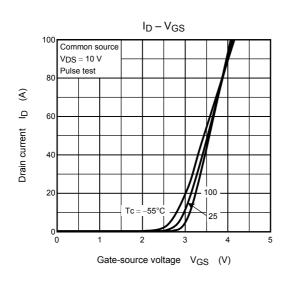
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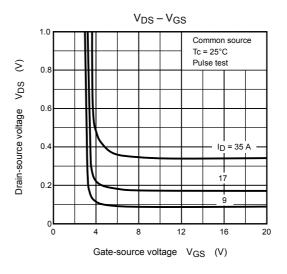


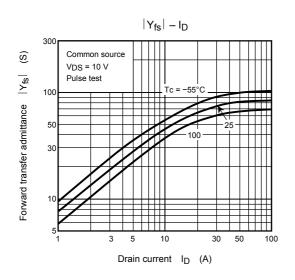
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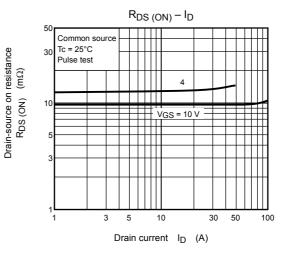




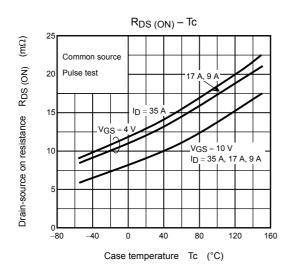


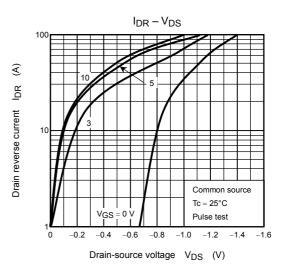


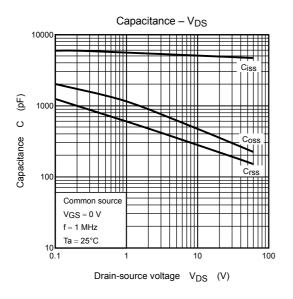


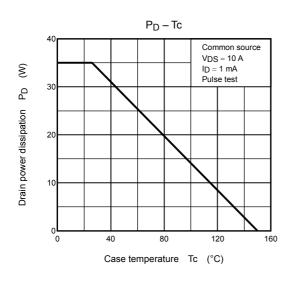


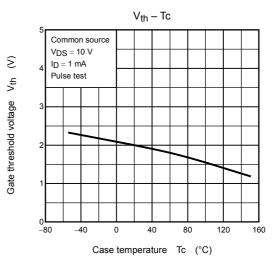
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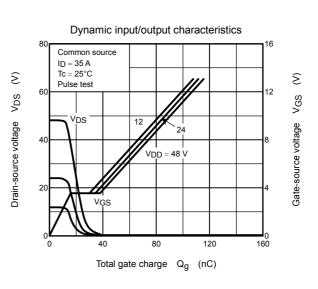


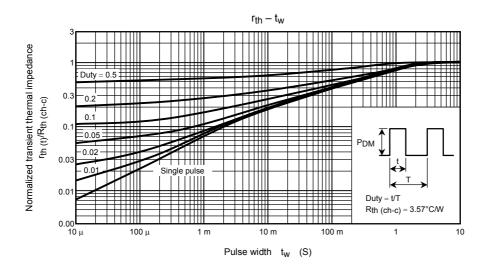




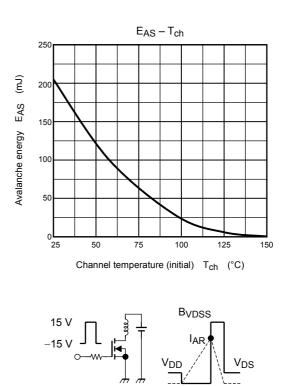








Safe operating area 300 ID max (pulsed)* 100 ID max (continuous) 1 ms¹ 30 E 10 ms Drain current ID 10 * Single nonrepetitive pulse $Tc = 25^{\circ}C$ 0.3 Curves must be derated linearly with increase in temperature. VDSS max 0.1 0.1 10 100 1 Drain-source voltage V_{DS} (V)





Waveform

Test circuit

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Handbook" etc.,

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